

Measuring Hydrogen Fluences in the Genesis Collectors: A Progress Report

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Summary of Last Year's Presentation

- Can get reproducible data if we control instrument conditions and stay ~ 1.5 mm from the edge of sample or holder mask.
- Can detect extraction-field distortions with E-gun and by comparing H/C with CH/C₂. First-order corrections are possible.
- Reported a beam-current dependence, but this was an artifact of our integration method.
- Standards did not agree with one another.

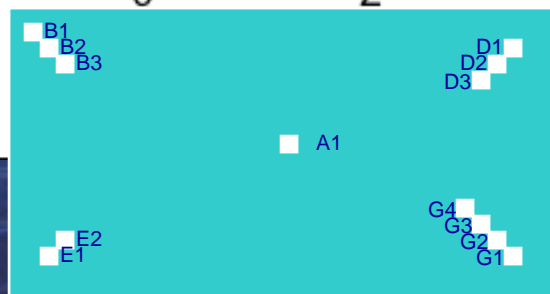
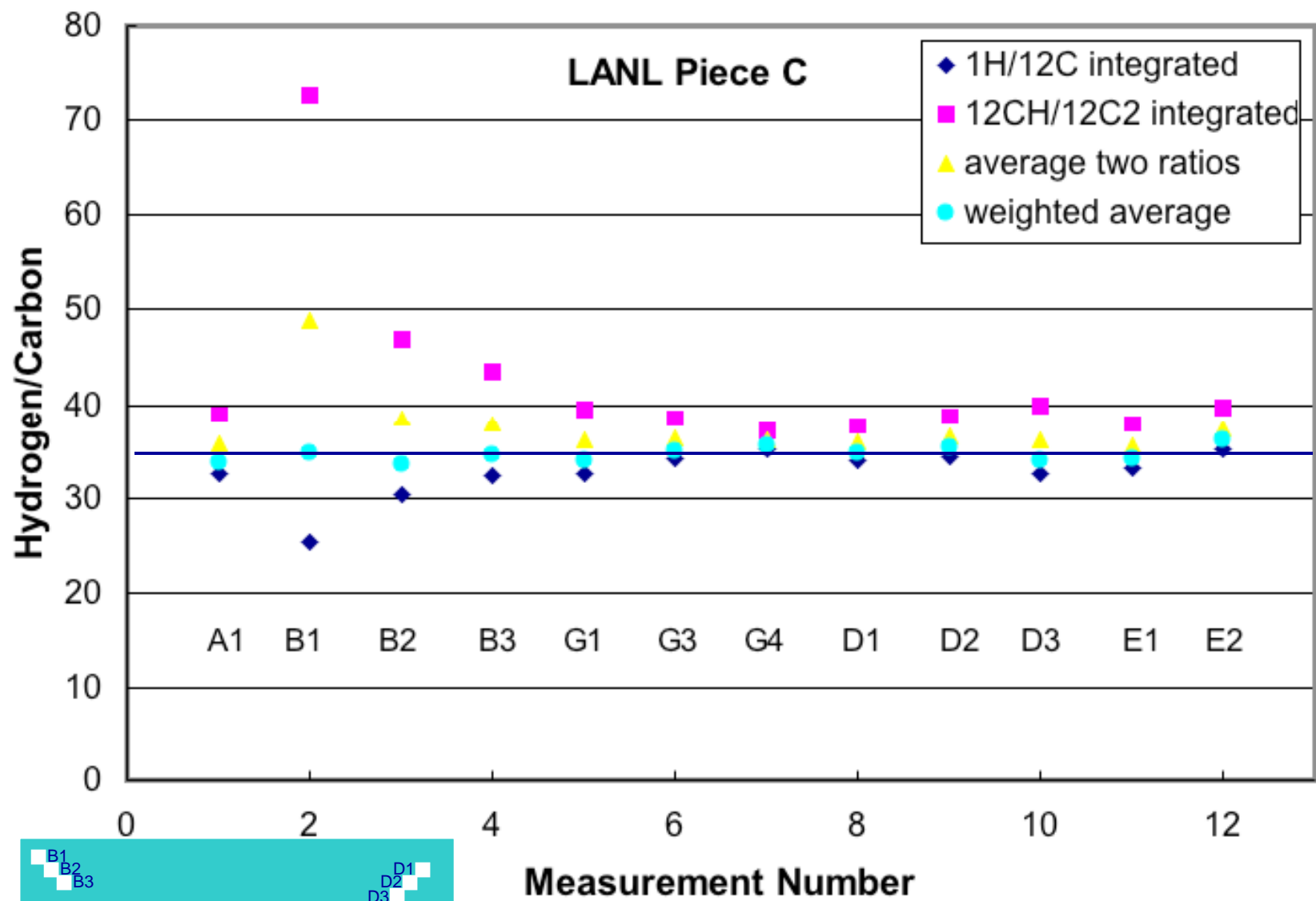
⇒ We estimated that measurements could be made with $\sim 5\%$ precision and accuracy (2σ).

During the Past 12 Months

- Obtained a new standard from Los Alamos National Lab with a nominal H fluence of $1.8 \times 10^{16}/\text{cm}^2$.
- Obtained new sample holders that better match the size of available GENESIS samples.
- Four DOS samples were allocated for measurement:
 - B/C array, E array, H array, L array
- Measured new and old standards to find a set that agree with each other.
- Revised measurement details to improve reproducibility and to better sample the shallow solar wind.

Analytical Conditions

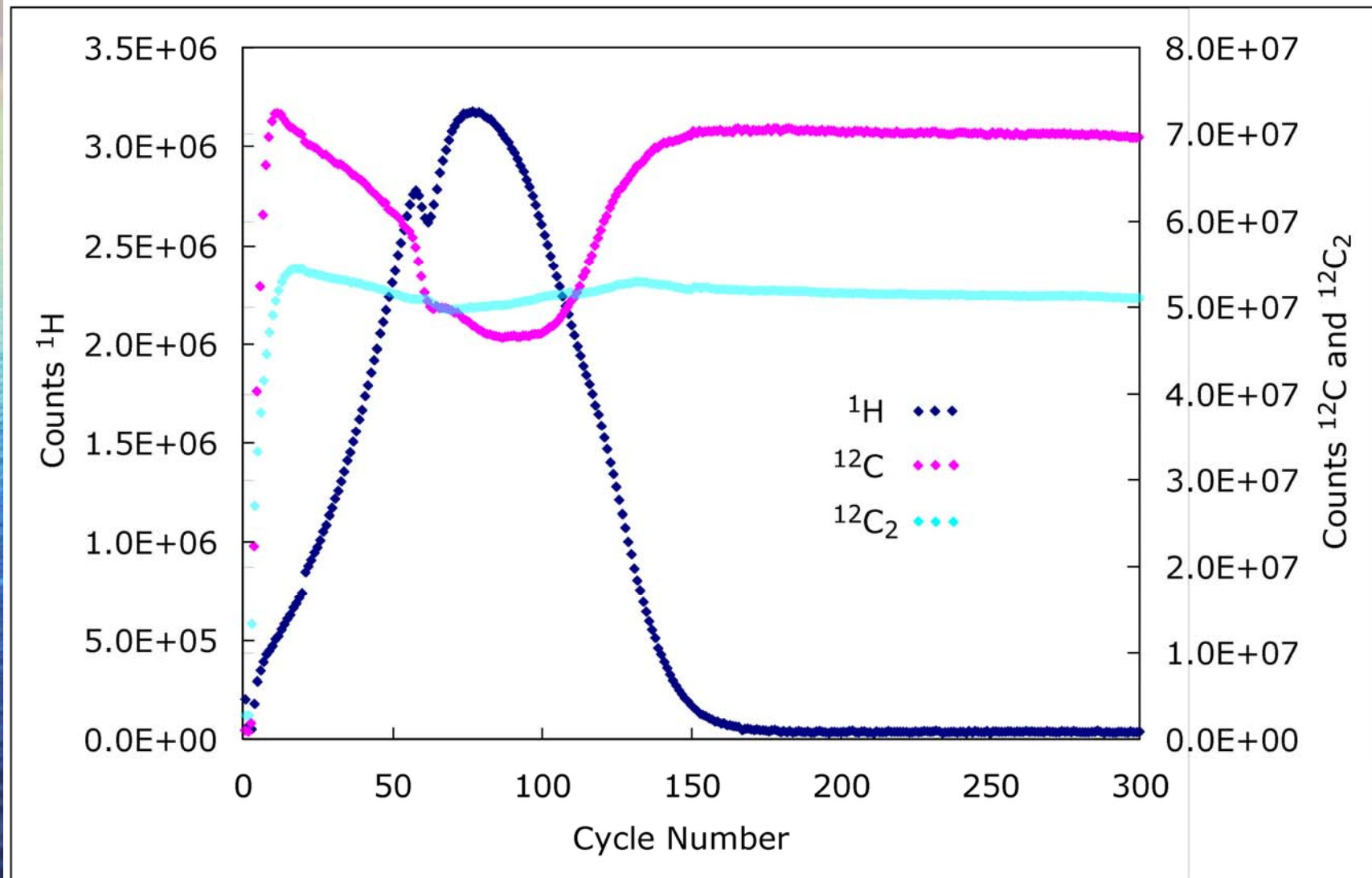
- Sample chamber vacuum $<5 \times 10^{-10}$ torr.
- Contrast aperture 150 μm . Field aperture open.
- 100x100 μm raster, E-gate 40% (central 25x25 μm area).
- Dynamic transfer system on.
- Automatic beam centering in field aperture.
- Mass resolving power ~ 3000 ($M/\Delta M$).
- Electron gun used to degas the sample surface and to evaluate extraction field. Not used during measurement.
- Primary beam current 1, 2, and 4 nAmps.
- Measured ^1H , ^{12}C , $^{12}\text{C}^1\text{H}$, $^{12}\text{C}_2$
 - 4 nA beam current: all on FC2 Faraday cup.
 - 1, 2nA beam currents: ^1H and ^{12}CH on EM, ^{12}C and $^{12}\text{C}_2$ on FC2



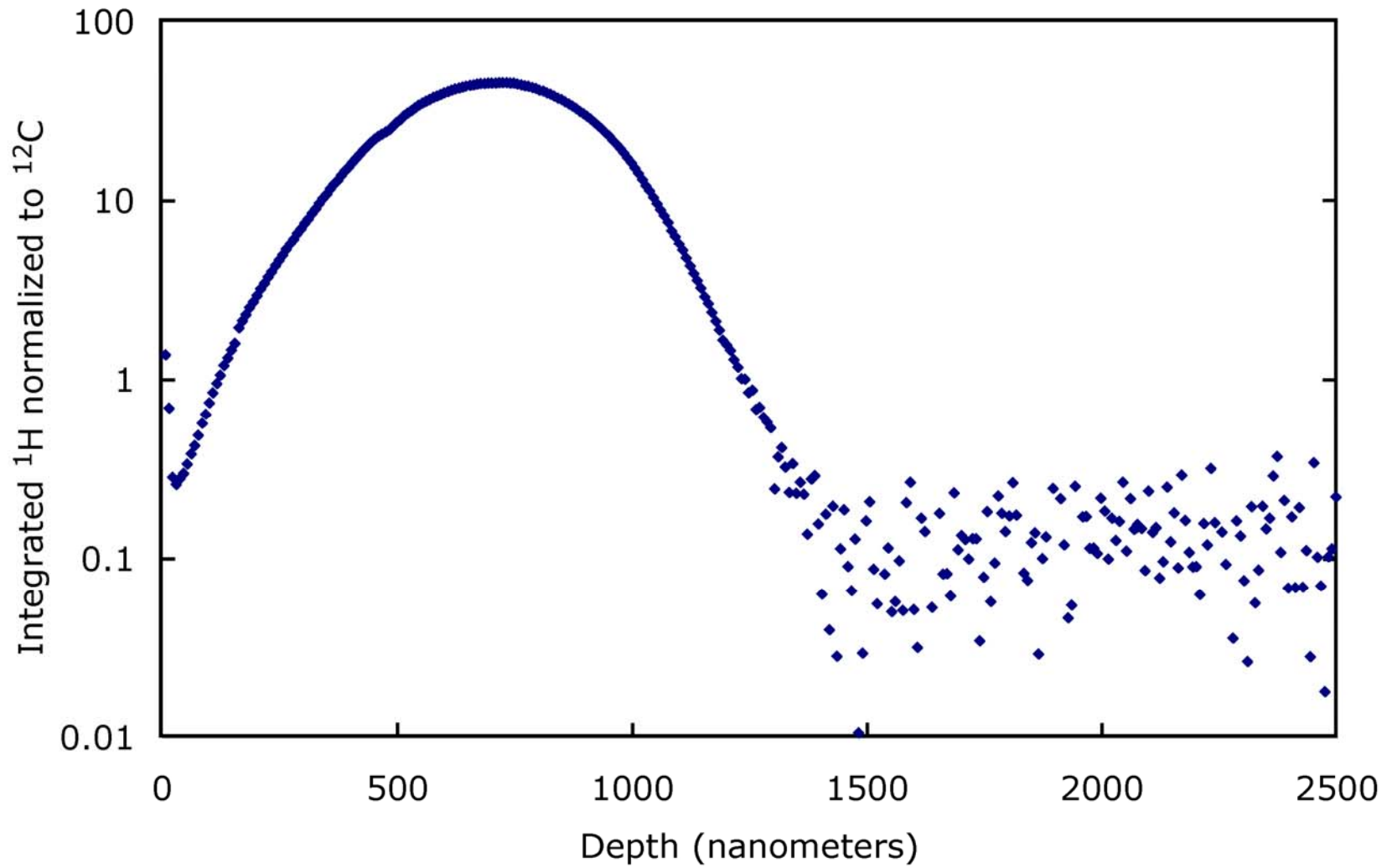
Standards

- New DOS standard from Los Alamos National Lab.
 - nominal H fluence: $1.8 \times 10^{16}/\text{cm}^2$, 18 keV.
- Previous standards:
 - Sandia-5, nominal fluence $1.5 \times 10^{17}/\text{cm}^2$, 14-20 keV
 - SWRI, nominal fluence $1.8 \times 10^{16}/\text{cm}^2$, 7.7 keV

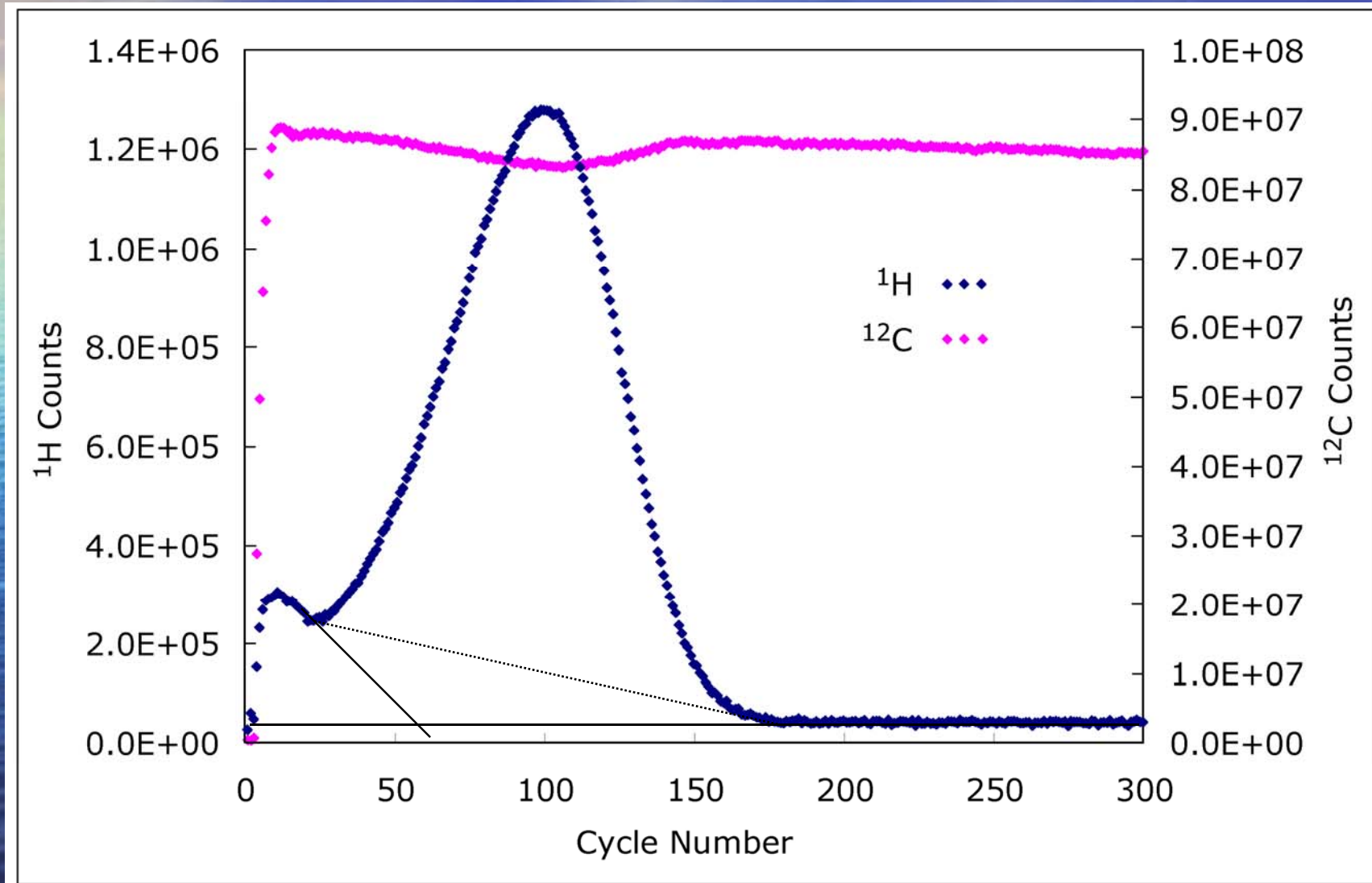
Sandia 5 Count-rate Profiles



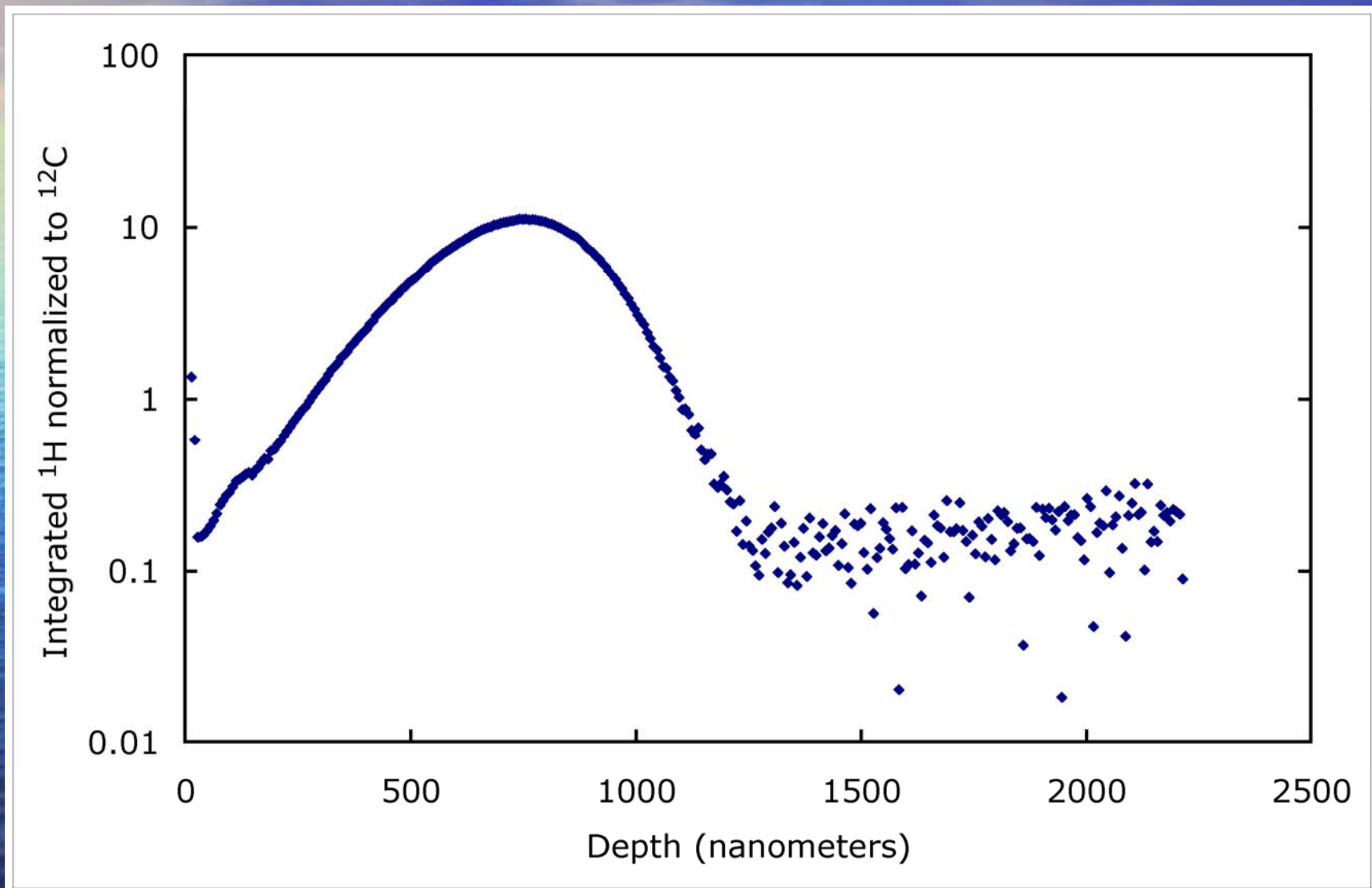
Sandia 5 $^1\text{H}/^{12}\text{C}$ ratio



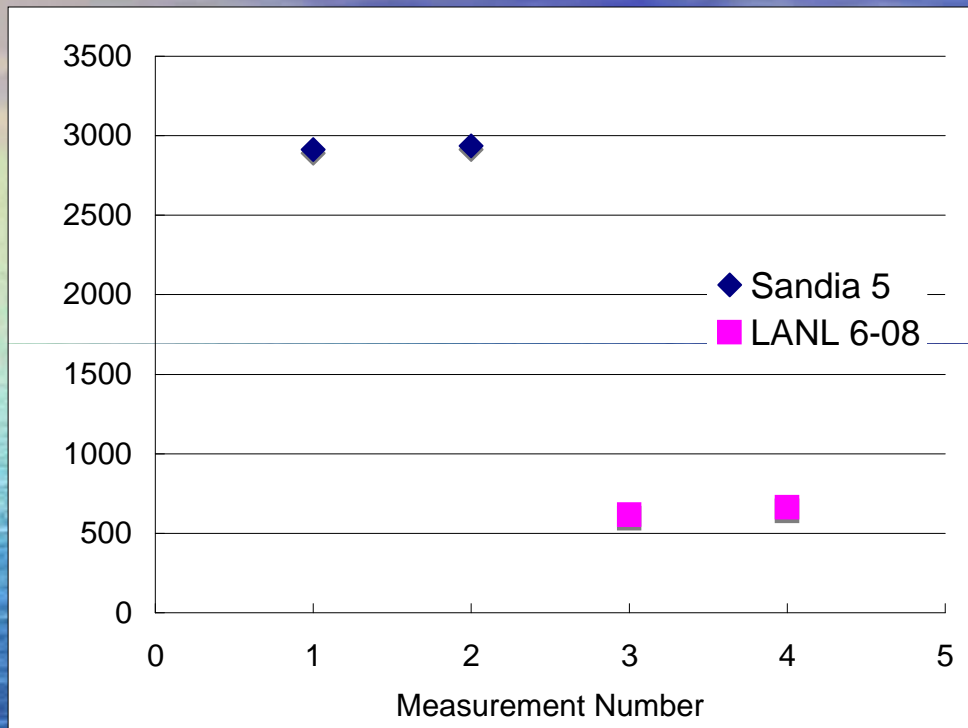
LANL 6-08 Count-rate Profiles



LANL 6-08 $^1\text{H}/^{12}\text{C}$ ratio



Compare Sandia 5 and LANL 6-08



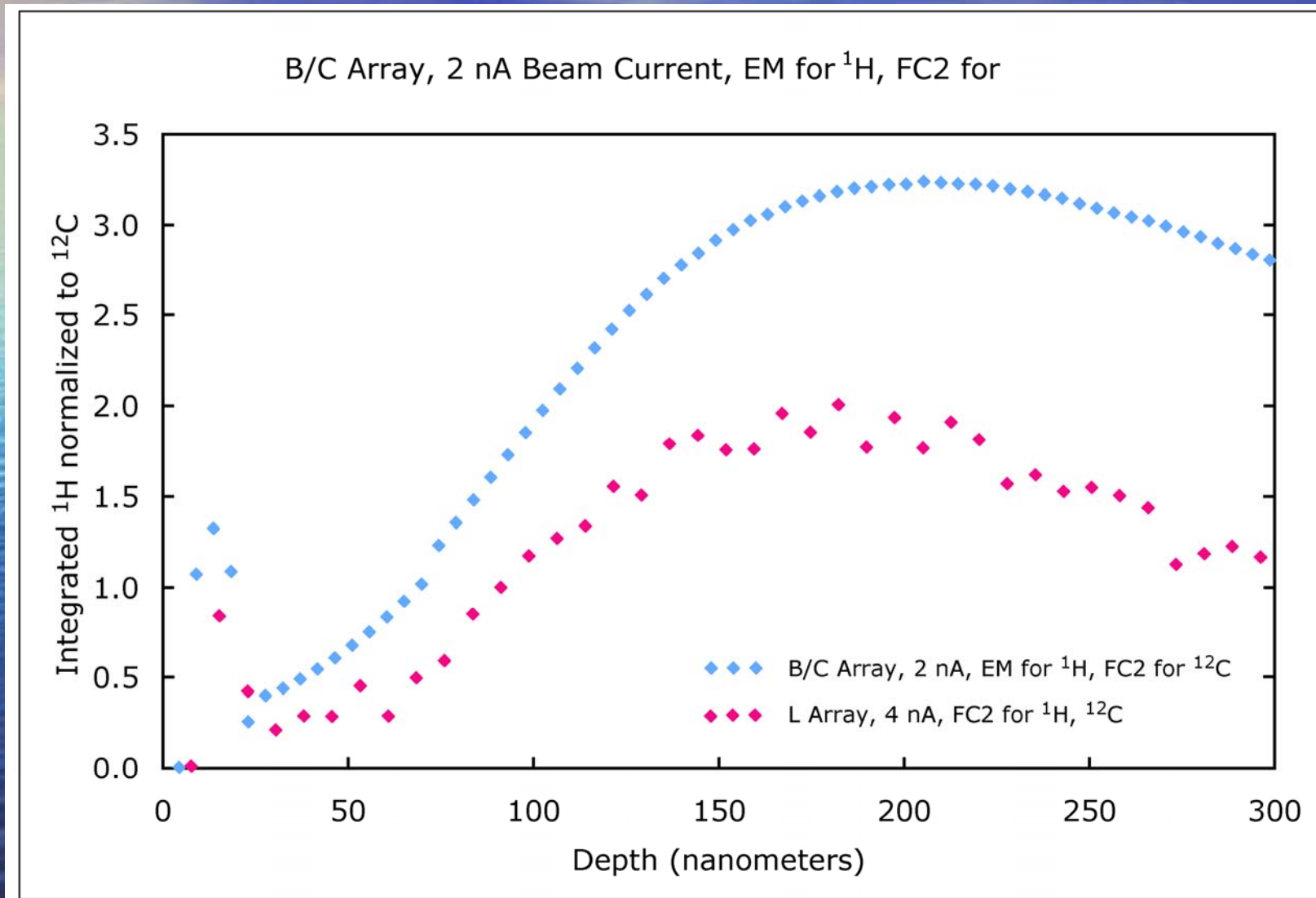
Conditions

- 4 nA primary beam
- 100 mm raster
- Egate 40%
- MRP ~4000
- Detector FC2

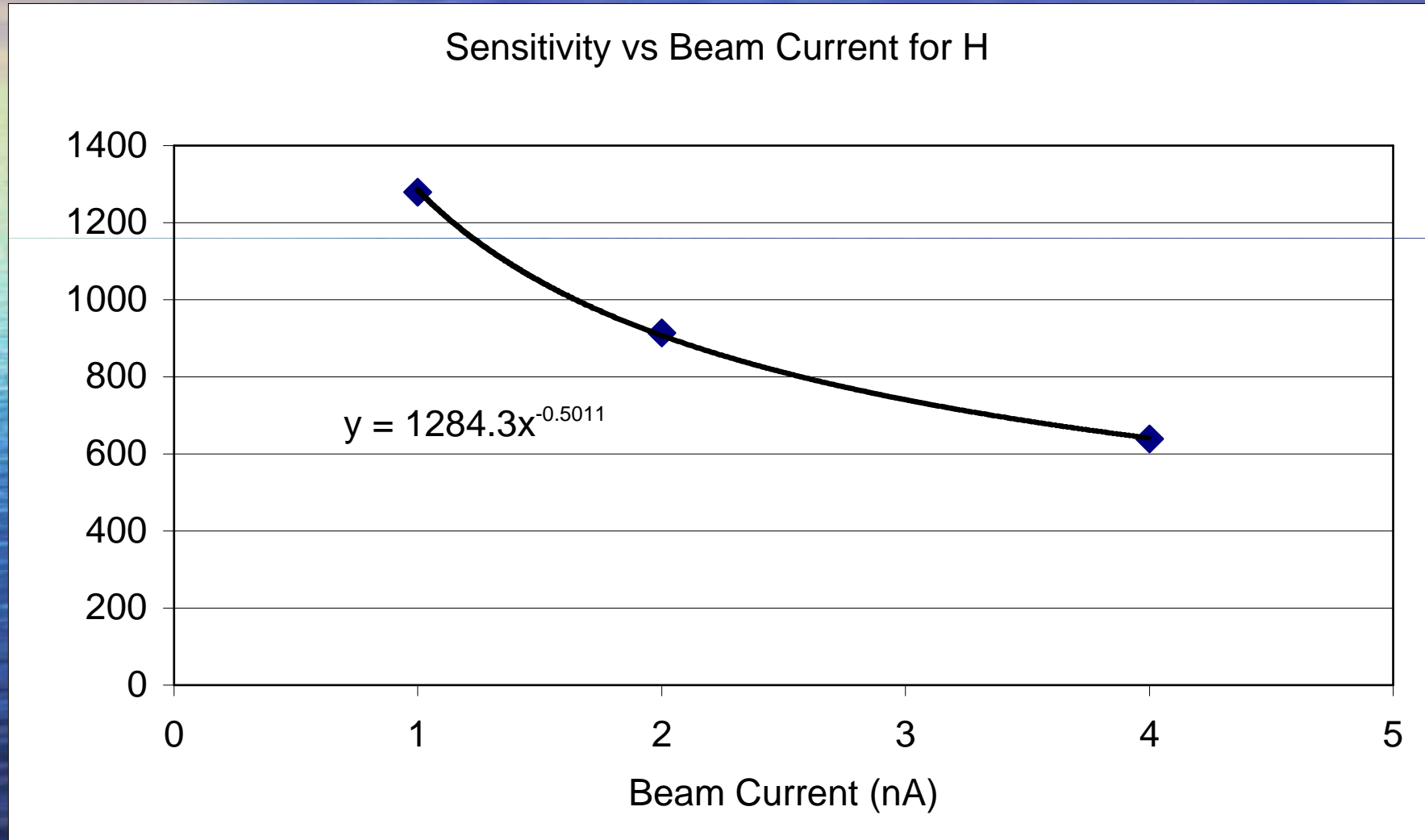
Nominal:	LANL 6-08	$1.8 \times 10^{16} / \text{cm}^2$		
	Sandia-5	$1.5 \times 10^{17} / \text{cm}^2$	Ratio	0.12
Measured:	LANL 6-08	638.8 ± 65.0		
	Sandia-5	2926.1 ± 33.2		Ratio

0.22

Minimizing Surface Transient Effects



Beam Current Dependence



What's next?

- Solve the problem with standardization.

Standards

- Previous DOS standards:
 - Sandia-5, nominal fluence $1.5 \times 10^{17}/\text{cm}^2$, 14-20 keV
 - SWRI, nominal fluence $1.8 \times 10^{16}/\text{cm}^2$, 7.7 keV
 - LANL 6-08, nominal fluence $1.8 \times 10^{16}/\text{cm}^2$, 18 keV
- New DOS standards:
 - Kroko, nominal fluence $2 \times 10^{15}/\text{cm}^2$, 15 keV
 - Kroko, nominal fluence $6 \times 10^{15}/\text{cm}^2$, 15 keV
- New Si standards:
 - SWRI, nominal fluence $1.8 \times 10^{16}/\text{cm}^2$, 7.7 keV
 - LANL 6-08, nominal fluence $1.8 \times 10^{16}/\text{cm}^2$, 18 keV
 - Kroko, nominal fluence $2 \times 10^{15}/\text{cm}^2$, 15 keV
 - Kroko, nominal fluence $6 \times 10^{15}/\text{cm}^2$, 15 keV

What's next?

- Solve the problem with standardization.
- Optimize measurement of the shallow portion of the implants.
- Make the measurements!